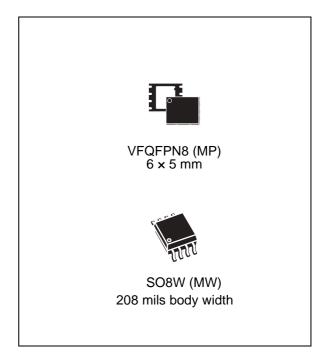


### **M45PE16**

# 16-Mbit, page-erasable serial flash memory with byte alterability and a 75 MHz SPI bus interface

#### **Features**

- SPI bus compatible serial interface
- 75 MHz clock rate (maximum)
- 16-Mbit page-erasable flash memory
- Page of 256 bytes
  - Page write in 11 ms (typical)
  - Page program in 0.8 ms (typical)
  - Page erase in 10 ms (typical)
- Sector erase (512 Kbits)
- Hardware write protection of the bottom sector (64 Kbytes)
- Electronic signature
  - JEDEC standard two-byte signature (4015h)
  - Unique ID code (UID) with 16 bytes readonly, available upon customer
- 2.7 to 3.6 V single supply voltage
- Deep power-down mode 1 µA (typical)
- More than 100 000 write cycles
- More than 20 years data retention
- Packages
  - ECOPACK® (RoHS compliant)



Contents M45PE16

# **Contents**

| 1 | Desc  | cription  | 6  |
|---|-------|---|----|
| 2 | Sign  | nal descriptions                                      | 8  |
|   | 2.1   | Serial data output (Q)                                | 8  |
|   | 2.2   | Serial data input (D)                                 | 8  |
|   | 2.3   | Serial Clock (C)                                      | 8  |
|   | 2.4   | Chip Select (S)                                       | 8  |
|   | 2.5   | Reset (Reset)   | 8  |
|   | 2.6   | Write Protect (W)                                     | 8  |
|   | 2.7   | V <sub>CC</sub> supply voltage                        | 9  |
|   | 2.8   | V <sub>SS</sub> ground                                | 9  |
| 3 | SPI   | modes   | 10 |
| 4 | Ope   | rating features                                       | 12 |
|   | 4.1   | Sharing the overhead of modifying data                | 12 |
|   | 4.2   | An easy way to modify data                            | 12 |
|   | 4.3   | A fast way to modify data                             | 13 |
|   | 4.4   | Polling during a write, program or erase cycle        | 13 |
|   | 4.5   | Reset   | 13 |
|   | 4.6   | Active power, standby power and deep power-down modes | 13 |
|   | 4.7   | Status register                                       | 14 |
|   | 4.8   | Protection modes                                      | 14 |
| 5 | Mem   | nory organization                                     | 15 |
| 6 | Instr | ructions  | 17 |
|   | 6.1   | Write enable (WREN)                                   | 18 |
|   | 6.2   | Write disable (WRDI)                                  | 19 |
|   | 6.3   | Read identification (RDID)                            | 20 |
|   | 6.4   | Read status register (RDSR)                           | 21 |
|   |       | 6.4.1 WIP bit   | 21 |
|   |       |   |    |

Numonyx

|    |        | 6.4.2 WEL bit                               | 21 |
|----|--------|---|----|
|    | 6.5    | Read data bytes (READ)                      | 22 |
|    | 6.6    | Read data bytes at higher speed (FAST_READ) | 23 |
|    | 6.7    | Page write (PW)                             | 24 |
|    | 6.8    | Page program (PP)                           | 26 |
|    | 6.9    | Page erase (PE)                             | 28 |
|    | 6.10   | Sector erase (SE)                           | 29 |
|    | 6.11   | Deep power-down (DP)                        | 30 |
|    | 6.12   | Release from deep power-down (RDP)          | 31 |
| 7  | Powe   | er-up and power-down                        | 32 |
| 8  | Initia | l delivery state                            | 34 |
| 9  | Maxi   | mum ratings                                 | 34 |
| 10 | DC a   | nd AC parameters                            | 35 |
| 11 | Pack   | age mechanical                              | 41 |
| 12 | Orde   | ring information                            | 44 |
| 13 | Ravis  | sion history                                | 15 |

List of tables M45PE16

# List of tables

| Table 1.  | Signal names  | 6  |
|-----------|---|----|
| Table 2.  | Memory organization   | 15 |
| Table 3.  | Instruction set   | 17 |
| Table 4.  | Read identification (RDID) data-out sequence                          | 20 |
| Table 5.  | Status register format  | 21 |
| Table 6.  | Power-up timing and VWI threshold                                     | 33 |
| Table 7.  | Absolute maximum ratings  | 34 |
| Table 8.  | Operating conditions  | 35 |
| Table 9.  | AC test measurement conditions  | 35 |
| Table 10. | Capacitance   | 35 |
| Table 11. | DC characteristics  | 36 |
| Table 12. | AC characteristics - 50 MHz operation                                 | 37 |
| Table 13. | AC characteristics - 75 MHz operation                                 | 38 |
| Table 14. | Reset conditions  | 40 |
| Table 15. | Timings after a Reset Low pulse                                       | 40 |
| Table 16. | VFQFPN8 (MLP8) 8-lead very thin fine pitch quad flat package no lead, |    |
|           | 6 x 5 mm, package mechanical data                                     | 42 |
| Table 17. | SO8W - 8 lead plastic small outline, 208 mils body width, package     |    |
|           | mechanical data   | 43 |
| Table 18. | Ordering information scheme   | 44 |
| Table 19. | Document revision history   | 45 |
|           |   |    |

M45PE16 List of figures

# **List of figures**

| Figure 1.  | Logic diagram   | 6    |
|------------|---|------|
| Figure 2.  | MLP and SO8 connections   |      |
| Figure 3.  | Bus master and memory devices on the SPI bus                              | . 10 |
| Figure 4.  | SPI modes supported   | . 11 |
| Figure 5.  | Block diagram   | . 16 |
| Figure 6.  | Write enable (WREN) instruction sequence                                  | . 18 |
| Figure 7.  | Write disable (WRDI) instruction sequence                                 | . 19 |
| Figure 8.  | Read identification (RDID) instruction sequence and data-out sequence     | . 20 |
| Figure 9.  | Read status register (RDSR) instruction sequence and data-out sequence    | . 21 |
| Figure 10. | Read data bytes (READ) instruction sequence and data-out sequence         | . 22 |
| Figure 11. | Read data bytes at higher speed (FAST_READ) instruction sequence          |      |
|            | and data-out sequence   | . 23 |
| Figure 12. | Page write (PW) instruction sequence                                      | . 25 |
| Figure 13. | Page program (PP) instruction sequence                                    | . 27 |
| Figure 14. | Page erase (PE) instruction sequence                                      | . 28 |
| Figure 15. | Sector erase (SE) instruction sequence                                    | . 29 |
| Figure 16. | Deep power-down (DP) instruction sequence                                 | . 30 |
| Figure 17. | Release from deep power-down (RDP) instruction sequence                   | . 31 |
| Figure 18. | Power-up timing   | . 33 |
| Figure 19. | AC test measurement I/O waveform  | . 35 |
| Figure 20. | Serial input timing   |      |
| Figure 21. | Write protect setup and hold timing                                       | . 39 |
| Figure 22. | Output timing   | . 39 |
| Figure 23. | Reset AC waveforms  | . 40 |
| Figure 24. | VFQFPN8 (MLP8) 8-lead very thin fine pitch quad flat package no lead,     |      |
|            | 6 x 5 mm, package outline   | . 41 |
| Figure 25. | SO8W - 8 lead plastic small outline, 208 mils body width, package outline | . 43 |
|            |   |      |

Numonyx 5/47

Description M45PE16

### 1 Description

The M45PE16 is a 16-Mbit (2 Mbit x8 bit) serial paged flash memory accessed by a high speed SPI-compatible bus.

The memory can be written or programmed 1 to 256 bytes at a time, using the page write or page program instruction. The page write instruction consists of an integrated page erase cycle followed by a page program cycle.

The memory is organized as 32 sectors, each containing 256 pages. Each page is 256-byte wide. Thus, the whole memory can be viewed as consisting of 8192 pages, or 2,097,152 bytes.

The memory can be erased a page at a time, using the page erase instruction, or a sector at a time, using the sector erase instruction.

#### Important note

Delivery of parts operating with a maximum clock rate of 75 MHz starts from week 8 of 2008.

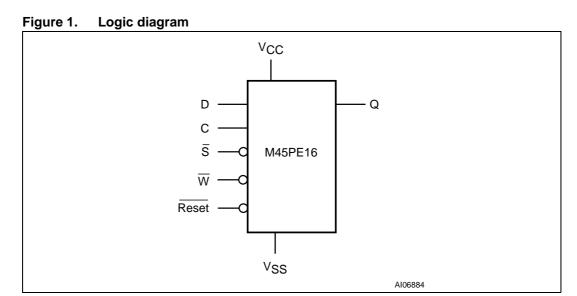
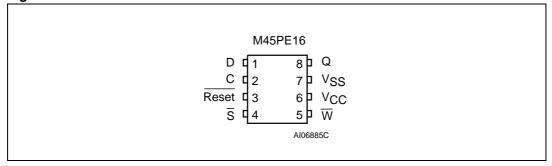


Table 1. Signal names

| Signal name     | Function           | Direction |
|-----------------|--------------------|-----------|
| С               | Serial Clock       | Input     |
| D               | Serial data input  | Input     |
| Q               | Serial data output | Output    |
| S               | Chip Select        | Input     |
| W               | Write Protect      | Input     |
| Reset           | Reset              | Input     |
| V <sub>CC</sub> | Supply voltage     |           |
| V <sub>SS</sub> | Ground             |           |

M45PE16 Description

Figure 2. MLP and SO8 connections



- There is an exposed central pad on the underside of the VFQFPN package. This is pulled, internally, to V<sub>SS</sub>, and must not be allowed to be connected to any other voltage or signal line on the PCB.
- 2. See Package mechanical section for package dimensions, and how to identify pin-1.

Signal descriptions M45PE16

### 2 Signal descriptions

#### 2.1 Serial data output (Q)

This output signal is used to transfer data serially out of the device. Data is shifted out on the falling edge of Serial Clock (C).

### 2.2 Serial data input (D)

This input signal is used to transfer data serially into the device. It receives instructions, addresses, and the data to be programmed. Values are latched on the rising edge of Serial Clock (C).

### 2.3 Serial Clock (C)

This input signal provides the timing of the serial interface. Instructions, addresses, or data present at serial data input (D) are latched on the rising edge of Serial Clock (C). Data on serial data output (Q) changes after the falling edge of Serial Clock (C).

### 2.4 Chip Select (S)

When this input signal is High, the device is deselected and serial data output (Q) is at high impedance. Unless an internal read, program, erase or write cycle is in progress, the device will be in the standby mode (this is not the deep power-down mode). Driving Chip Select  $(\overline{S})$  Low enables the device, placing it in the active power mode.

After power-up, a falling edge on Chip Select  $(\overline{S})$  is required prior to the start of any instruction.

### 2.5 Reset (Reset)

The Reset (Reset) input provides a hardware reset for the memory.

When Reset (Reset) is driven High, the memory is in the normal operating mode. When Reset (Reset) is driven Low, the device enters the reset mode. In this mode, the output Q is high impedance.

If an internal operation (write, erase or program cycle) is in progress when Reset (Reset) is driven Low, the device enters the reset mode and any on-going write, program or erase cycle is aborted. The addressed data may be lost.

### 2.6 Write Protect $(\overline{W})$

This input signal puts the device in the hardware protected mode, when Write Protect (W) is connected to  $V_{SS}$ , causing the first 256 pages of memory to become read-only by protecting them from write, program and erase operations. When Write Protect  $(\overline{W})$  is connected to  $V_{CC}$ , the first 256 pages of memory behave like the other pages of memory.

M45PE16 Signal descriptions

# 2.7 V<sub>CC</sub> supply voltage

V<sub>CC</sub> is the supply voltage.

### 2.8 V<sub>SS</sub> ground

 $\rm V_{SS}$  is the reference for the  $\rm V_{CC}$  supply voltage.

Numonyx 9/47

SPI modes M45PE16

#### 3 SPI modes

These devices can be driven by a microcontroller with its SPI peripheral running in either of the two following modes:

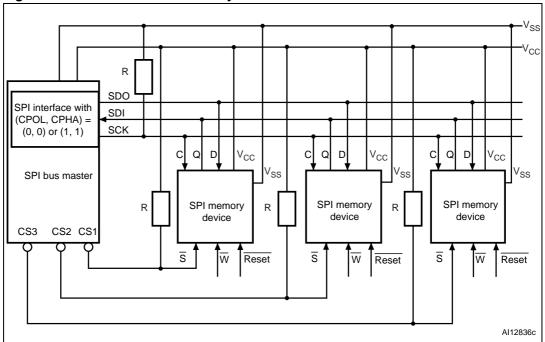
- CPOL=0, CPHA=0
- CPOL=1, CPHA=1

For these two modes, input data is latched in on the rising edge of Serial Clock (C), and output data is available from the falling edge of Serial Clock (C).

The difference between the two modes, as shown in *Figure 4*, is the clock polarity when the bus master is in Stand-by mode and not transferring data:

- C remains at 0 for (CPOL=0, CPHA=0)
- C remains at 1 for (CPOL=1, CPHA=1)

Figure 3. Bus master and memory devices on the SPI bus



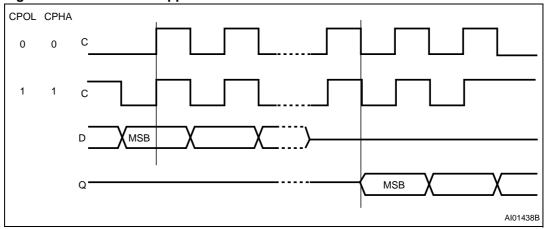
1. The Write Protect  $(\overline{W})$  signal should be driven, High or Low as appropriate.

Figure 3 shows an example of three devices connected to an MCU, on an SPI bus. Only one device is selected at a time, so only one device drives the serial data output (Q) line at a time, the other devices are high impedance. Resistors R (represented in Figure 3) ensure that the M45PE16 is not selected if the bus master leaves the  $\overline{S}$  line in the high impedance state. As the bus master may enter a state where all inputs/outputs are in high impedance at the same time (for example, when the bus master is reset), the clock line (C) must be connected to an external pull-down resistor so that, when all inputs/outputs become high impedance, the  $\overline{S}$  line is pulled High while the C line is pulled Low (thus ensuring that  $\overline{S}$  and C do not become High at the same time, and so, that the  $t_{SHCH}$  requirement is met). The typical value of R is 100 kΩ, assuming that the time constant R\*C<sub>p</sub> (C<sub>p</sub> = parasitic capacitance of the bus line) is shorter than the time during which the bus master leaves the SPI bus in high impedance.

M45PE16 SPI modes

**Example:**  $C_p = 50$  pF, that is  $R^*C_p = 5$   $\mu s <=>$  the application must ensure that the bus master never leaves the SPI bus in the high impedance state for a time period shorter than 5  $\mu s$ .

Figure 4. SPI modes supported



Numonyx 11/47

Operating features M45PE16

### 4 Operating features

#### 4.1 Sharing the overhead of modifying data

To write or program one (or more) data bytes, two instructions are required: write enable (WREN), which is one byte, and a page write (PW) or page program (PP) sequence, which consists of four bytes plus data. This is followed by the internal cycle (of duration t<sub>PW</sub> or t<sub>PP</sub>).

To share this overhead, the page write (PW) or page program (PP) instruction allows up to 256 bytes to be programmed (changing bits from '1' to '0') or written (changing bits to '0' or '1') at a time, provided that they lie in consecutive addresses on the same page of memory.

### 4.2 An easy way to modify data

The page write (PW) instruction provides a convenient way of modifying data (up to 256 contiguous bytes at a time), and simply requires the start address, and the new data in the instruction sequence.

The page write (PW) instruction is entered by driving Chip Select  $(\overline{S})$  Low, and then transmitting the instruction byte, three address bytes (A23-A0) and at least one data byte, and then driving Chip Select  $(\overline{S})$  High. While Chip Select  $(\overline{S})$  is being held Low, the data bytes are written to the data buffer, starting at the address given in the third address byte (A7-A0). When Chip Select  $(\overline{S})$  is driven High, the write cycle starts. The remaining, unchanged, bytes of the data buffer are automatically loaded with the values of the corresponding bytes of the addressed memory page. The addressed memory page then automatically put into an erase cycle. Finally, the addressed memory page is programmed with the contents of the data buffer.

All of this buffer management is handled internally, and is transparent to the user. The user is given the facility of being able to alter the contents of the memory on a byte-by-byte basis.

For optimized timings, it is recommended to use the page write (PW) instruction to write all consecutive targeted bytes in a single sequence versus using several page write (PW) sequences with each containing only a few bytes (see Section 6.7: Page write (PW), Table 12: AC characteristics - 50 MHz operation, and Table 13: AC characteristics - 75 MHz operation).

M45PE16 Operating features

### 4.3 A fast way to modify data

The page program (PP) instruction provides a fast way of modifying data (up to 256 contiguous bytes at a time), provided that it only involves resetting bits to '0' that had previously been set to '1'.

This might be:

- when the designer is programming the device for the first time
- when the designer knows that the page has already been erased by an earlier page erase (PE) or sector erase (SE) instruction. This is useful, for example, when storing a fast stream of data, having first performed the erase cycle when time was available
- when the designer knows that the only changes involve resetting bits to '0' that are still set to '1'. When this method is possible, it has the additional advantage of minimizing the number of unnecessary erase operations, and the extra stress incurred by each page.

For optimized timings, it is recommended to use the page program (PP) instruction to program all consecutive targeted bytes in a single sequence versus using several page program (PP) sequences with each containing only a few bytes (see Section 6.8: Page program (PP), Table 12: AC characteristics - 50 MHz operation, and Table 13: AC characteristics - 75 MHz operation).

### 4.4 Polling during a write, program or erase cycle

A further improvement in the write, program or erase time can be achieved by not waiting for the worst case delay ( $t_{PW}$ ,  $t_{PP}$ , or  $t_{SE}$ ). The write in progress (WIP) bit is provided in the status register so that the application program can monitor its value, polling it to establish when the previous cycle is complete.

#### 4.5 Reset

An internal power-on reset circuit helps <u>protect</u> against inadvertent data writes. Addition protection is provided by driving Reset ( $\overline{\text{Reset}}$ ) Low during the power-on process, and only driving it High when  $V_{CC}$  has reached the correct voltage level,  $V_{CC}$ (min).

### 4.6 Active power, standby power and deep power-down modes

When Chip Select  $(\overline{S})$  is Low, the device is enabled, and in the active power mode.

When Chip Select  $(\overline{S})$  is High, the device is disabled, but could remain in the active power mode until all internal cycles have completed (program, erase, write). The device then goes in to the standby power mode. The device consumption drops to  $I_{CC1}$ .

The deep power-down mode is entered when the specific instruction (the enter deep power-down mode (DP) instruction) is executed. The device consumption drops further to  $I_{CC2}$ . The device remains in this mode until another specific instruction (the release from deep power-down mode and read electronic signature (RES) instruction) is executed.

All other instructions are ignored while the device is in the deep power-down mode. This can be used as an extra software protection mechanism, when the device is not in active use, to protect the device from inadvertent write, program or erase instructions.

**№** numonyx 13/47

Operating features M45PE16

### 4.7 Status register

The status register contains two status bits that can be read by the read status register (RDSR) instruction. See Section 6.4: Read status register (RDSR) for a detailed description of the status register bits.

#### 4.8 Protection modes

The environments where non-volatile memory devices are used can be very noisy. No SPI device can operate correctly in the presence of excessive noise. To help combat this, the M45PE16 boasts the following data protection mechanisms:

- Power-on reset and an internal timer (t<sub>PUW</sub>) can provide protection against inadvertent changes while the power supply is outside the operating specification.
- Program, erase and write instructions are checked that they consist of a number of clock pulses that is a multiple of eight, before they are accepted for execution.
- All instructions that modify data must be preceded by a write enable (WREN)
  instruction to set the write enable latch (WEL) bit. This bit is returned to its reset state
  by the following events:
  - Power-up
  - Reset (Reset) driven Low
  - Write disable (WRDI) instruction completion
  - Page write (PW) instruction completion
  - Page program (PP) instruction completion
  - Page erase (PE) instruction completion
  - Sector erase (SE) instruction completion
- The hardware protected mode is entered when Write Protect (W) is driven Low, causing the first 256 pages of memory to become read-only. When Write Protect (W) is driven High, the first 256 pages of memory behave like the other pages of memory
- In addition to the low power consumption feature, the deep power-down mode offers extra software protection from inadvertent write, program and erase instructions while the device is not in active use.

# 5 Memory organization

The memory is organized as:

- 8192 pages (256 bytes each).
- 2,097,152 bytes (8 bits each)
- 32 sectors (512 Kbits, 65536 bytes each)

Each page can be individually:

- programmed (bits are programmed from 1 to 0)
- erased (bits are erased from 0 to 1)
- written (bits are changed to either 0 or 1)

The device is page or sector erasable (bits are erased from 0 to 1).

Table 2. Memory organization

| Sector | Address range |         |  |
|--------|---------------|---------|--|
| 31     | 1F0000h       | 1FFFFFh |  |
| 30     | 1E0000h       | 1EFFFFh |  |
| 29     | 1D0000h       | 1DFFFFh |  |
| 28     | 1C0000h       | 1CFFFFh |  |
| 27     | 1B0000h       | 1BFFFFh |  |
| 26     | 1A0000h       | 1AFFFFh |  |
| 25     | 190000h       | 19FFFFh |  |
| 24     | 180000h       | 18FFFFh |  |
| 23     | 170000h       | 17FFFFh |  |
| 22     | 160000h       | 16FFFFh |  |
| 21     | 150000h       | 15FFFFh |  |
| 20     | 140000h       | 14FFFFh |  |
| 19     | 130000h       | 13FFFFh |  |
| 18     | 120000h       | 12FFFFh |  |
| 17     | 110000h       | 11FFFFh |  |
| 16     | 100000h       | 10FFFFh |  |
| 15     | 0F0000h       | 0FFFFFh |  |
| 14     | 0E0000h       | 0EFFFFh |  |
| 13     | 0D0000h       | 0DFFFFh |  |
| 12     | 0C0000h       | 0CFFFFh |  |
| 11     | 0B0000h       | 0BFFFFh |  |
| 10     | 0A0000h       | 0AFFFFh |  |
| 9      | 090000h       | 09FFFFh |  |
| 8      | 080000h       | 08FFFFh |  |

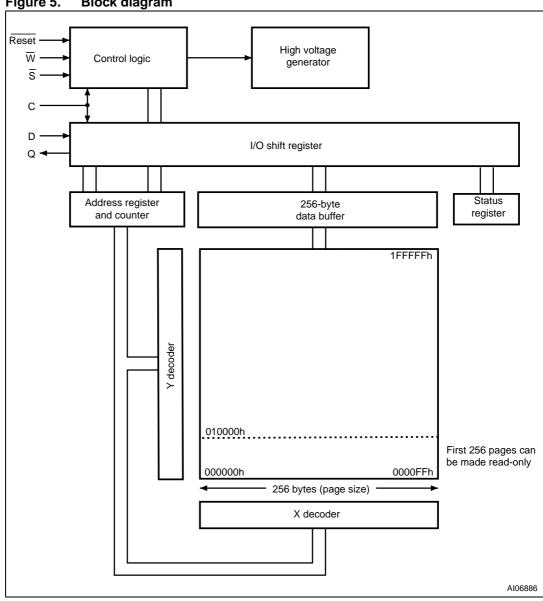
Numonyx 15/47

M45PE16 Memory organization

Table 2. Memory organization (continued)

| Sector | Address range |         |  |
|--------|---------------|---------|--|
| 7      | 070000h       | 07FFFFh |  |
| 6      | 060000h       | 06FFFFh |  |
| 5      | 050000h       | 05FFFFh |  |
| 4      | 040000h       | 04FFFFh |  |
| 3      | 030000h       | 03FFFFh |  |
| 2      | 020000h       | 02FFFFh |  |
| 1      | 010000h       | 01FFFFh |  |
| 0      | 000000h       | 00FFFFh |  |

Figure 5. **Block diagram** 



**N** numonyx 16/47

M45PE16 Instructions

#### 6 Instructions

All instructions, addresses and data are shifted in and out of the device, most significant bit first.

Serial data input (D) is sampled on the first rising edge of Serial Clock (C) after Chip Select  $(\overline{S})$  is driven Low. Then, the one-byte instruction code must be shifted in to the device, most significant bit first, on serial data input (D), each bit being latched on the rising edges of Serial Clock (C).

The instruction set is listed in *Table 3*.

Every instruction sequence starts with a one-byte instruction code. Depending on the instruction, this might be followed by address bytes, or by data bytes, or by both or none.

In the case of a read data bytes (READ), read data bytes at higher speed (FAST\_READ) or read status register (RDSR) instruction, the shifted-in instruction sequence is followed by a data-out sequence. Chip Select  $(\overline{S})$  can be driven High after any bit of the data-out sequence is being shifted out.

In the case of a page write (PW), page program (PP), page erase (PE), sector erase (SE), write enable (WREN), write disable (WRDI), deep power-down (DP) or release from deep power-down (RDP) instruction, Chip Select  $(\overline{S})$  must be driven High exactly at a byte boundary, otherwise the instruction is rejected, and is not executed. That is, Chip Select  $(\overline{S})$  must driven High when the number of clock pulses after Chip Select  $(\overline{S})$  being driven Low is an exact multiple of eight.

All attempts to access the memory array during a write cycle, program cycle or erase cycle are ignored, and the internal write cycle, program cycle or erase cycle continues unaffected.

Table 3. Instruction set

| Instruction | Description                     | One-byte instruction code |     | Address<br>bytes | Dummy<br>bytes | Data<br>bytes |
|-------------|---------------------------------|---------------------------|-----|------------------|----------------|---------------|
| WREN        | Write enable                    | 0000 0110                 | 06h | 0                | 0              | 0             |
| WRDI        | Write disable                   | 0000 0100                 | 04h | 0                | 0              | 0             |
| RDID        | Read identification             | 1001 1111                 | 9Fh | 0                | 0              | 1 to 3        |
| RDSR        | Read status register            | 0000 0101                 | 05h | 0                | 0              | 1 to ∞        |
| READ        | Read data bytes                 | 0000 0011                 | 03h | 3                | 0              | 1 to ∞        |
| FAST_READ   | Read data bytes at higher speed | 0000 1011                 | 0Bh | 3                | 1              | 1 to ∞        |
| PW          | Page write                      | 0000 1010                 | 0Ah | 3                | 0              | 1 to 256      |
| PP          | Page program                    | 0000 0010                 | 02h | 3                | 0              | 1 to 256      |
| PE          | Page erase                      | 1101 1011                 | DBh | 3                | 0              | 0             |
| SE          | Sector erase                    | 1101 1000                 | D8h | 3                | 0              | 0             |
| DP          | Deep power-down                 | 1011 1001                 | B9h | 0                | 0              | 0             |
| RDP         | Release from deep power-down    | 1010 1011                 | ABh | 0                | 0              | 0             |

Instructions M45PE16

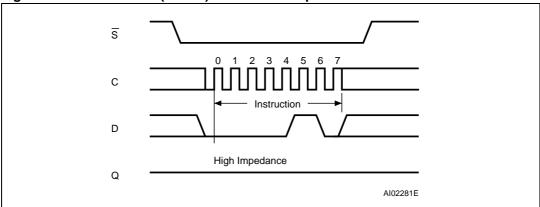
### 6.1 Write enable (WREN)

The write enable (WREN) instruction (Figure 6) sets the write enable latch (WEL) bit.

The write enable latch (WEL) bit must be set prior to every page write (PW), page program (PP), page erase (PE), and sector erase (SE) instruction.

The write enable (WREN) instruction is entered by driving Chip Select  $(\overline{S})$  Low, sending the instruction code, and then driving Chip Select  $(\overline{S})$  High.

Figure 6. Write enable (WREN) instruction sequence



M45PE16 Instructions

### 6.2 Write disable (WRDI)

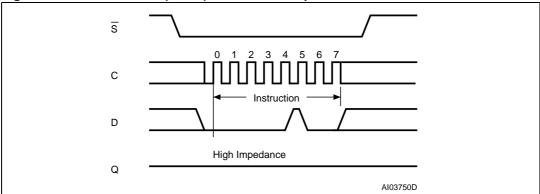
The write disable (WRDI) instruction (Figure 7) resets the write enable latch (WEL) bit.

The write disable (WRDI) instruction is entered by driving Chip Select  $(\overline{S})$  Low, sending the instruction code, and then driving Chip Select  $(\overline{S})$  High.

The write enable latch (WEL) bit is reset under the following conditions:

- Power-up
- Write disable (WRDI) instruction completion
- Page write (PW) instruction completion
- Page program (PP) instruction completion
- Page erase (PE) instruction completion
- Sector erase (SE) instruction completion

Figure 7. Write disable (WRDI) instruction sequence



Instructions M45PE16

### 6.3 Read identification (RDID)

The read identification (RDID) instruction allows to read the device identification data:

- Manufacturer identification (1 byte)
- Device identification (2 bytes)
- A unique ID code (UID) (17 bytes, of which 16 available upon customer request).

The manufacturer identification is assigned by JEDEC, and has the value 20h for Numonyx. The device identification is assigned by the device manufacturer, and indicates the memory type in the first byte (40h), and the memory capacity of the device in the second byte (15h). The UID contains the length of the following data in the first byte (set to 10h), and 16 bytes of the optional customized factory data (CFD) content. The CFD bytes are read-only and can be programmed with customers data upon their demand. If the customers do not make requests, the devices are shipped with all the CFD bytes programmed to zero (00h).

Any read identification (RDID) instruction while an erase or program cycle is in progress, is not decoded, and has no effect on the cycle that is in progress.

The device is first selected by driving Chip Select  $(\overline{S})$  Low. Then, the 8-bit instruction code for the instruction is shifted in. After this, the 24-bit device identification, stored in the memory, the 8-bit CFD length followed by 16 bytes of CFD content will be shifted out on serial data output (Q). Each bit is shifted out during the falling edge of Serial Clock (C).

The instruction sequence is shown in Figure 8.

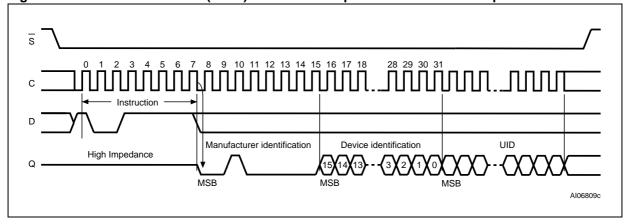
The read identification (RDID) instruction is terminated by driving Chip Select  $(\overline{S})$  High at any time during data output.

When Chip Select  $(\overline{S})$  is driven High, the device is put in the standby power mode. Once in the standby power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

Table 4. Read identification (RDID) data-out sequence

| Manufacturer identification | Device id   | dentification   | UID        |             |  |
|-----------------------------|-------------|-----------------|------------|-------------|--|
| Wandiacturer Identification | Memory type | Memory capacity | CFD length | CFD content |  |
| 20h                         | 40h         | 15h             | 10h        | 16 bytes    |  |

Figure 8. Read identification (RDID) instruction sequence and data-out sequence



M45PE16 Instructions

### 6.4 Read status register (RDSR)

The read status register (RDSR) instruction allows the status register to be read. The status register may be read at any time, even while a program, erase or write cycle is in progress. When one of these cycles is in progress, it is recommended to check the write in progress (WIP) bit before sending a new instruction to the device. It is also possible to read the status register continuously, as shown in *Figure 9*.

The status bits of the status register are as follows:

#### 6.4.1 WIP bit

The write in progress (WIP) bit indicates whether the memory is busy with a write, program or erase cycle. When set to '1', such a cycle is in progress, when reset to '0' no such cycle is in progress.

#### 6.4.2 WEL bit

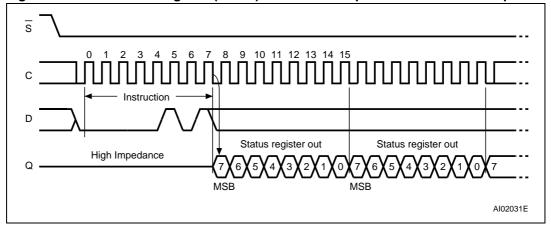
The write enable latch (WEL) bit indicates the status of the internal write enable latch. When set to '1' the internal write enable latch is set, when set to '0' the internal write enable latch is reset and no write, program or erase instruction is accepted.

Table 5. Status register format

| b7 |   |   |   |   |   |                    | b0                 |  |
|----|---|---|---|---|---|--------------------|--------------------|--|
| 0  | 0 | 0 | 0 | 0 | 0 | WEL <sup>(1)</sup> | WIP <sup>(1)</sup> |  |

WEL and WIP are volatile read-only bits (WEL is set and reset by specific instructions; WIP is automatically set and reset by the internal logic of the device).

Figure 9. Read status register (RDSR) instruction sequence and data-out sequence



Numonyx 21/47

Instructions M45PE16

### 6.5 Read data bytes (READ)

The device is first selected by driving Chip Select  $(\overline{S})$  Low. The instruction code for the read data bytes (READ) instruction is followed by a 3-byte address (A23-A0), each bit being latched-in during the rising edge of Serial Clock (C). Then the memory contents, at that address, is shifted out on serial data output (Q), each bit being shifted out, at a maximum frequency  $f_R$ , during the falling edge of Serial Clock (C).

The instruction sequence is shown in *Figure 10*.

The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single read data bytes (READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The read data bytes (READ) instruction is terminated by driving Chip Select  $(\overline{S})$  High. Chip Select  $(\overline{S})$  can be driven High at any time during data output. Any read data bytes (READ) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

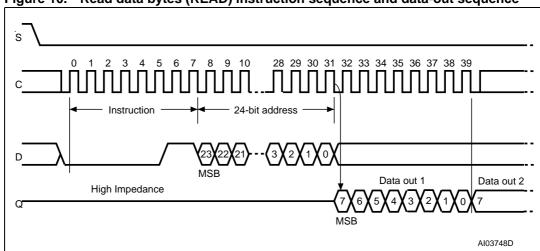


Figure 10. Read data bytes (READ) instruction sequence and data-out sequence

1. Address bits A23 to A21 are don't care.

M45PE16 Instructions

### 6.6 Read data bytes at higher speed (FAST\_READ)

The device is first selected by driving Chip Select  $(\overline{S})$  Low. The instruction code for the read data bytes at higher speed (FAST\_READ) instruction is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of Serial Clock (C). Then the memory contents, at that address, is shifted out on serial data output (Q), each bit being shifted out, at a maximum frequency  $f_C$ , during the falling edge of Serial Clock (C).

The instruction sequence is shown in Figure 11.

The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single read data bytes at higher speed (FAST\_READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The read data bytes at higher speed (FAST\_READ) instruction is terminated by driving Chip Select  $(\overline{S})$  High. Chip Select  $(\overline{S})$  can be driven High at any time during data output. Any read data bytes at higher speed (FAST\_READ) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

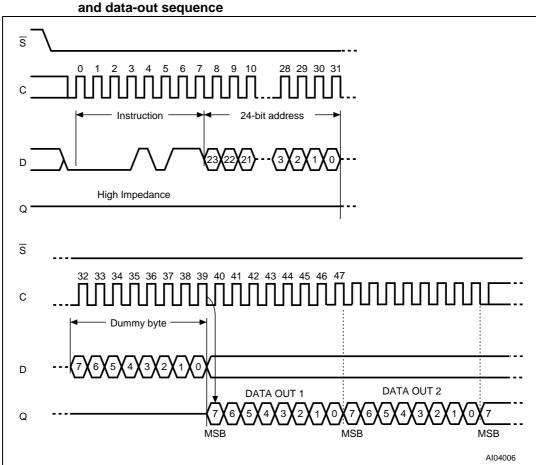


Figure 11. Read data bytes at higher speed (FAST\_READ) instruction sequence and data-out sequence

1. Address bits A23 to A21 are don't care.

Numonyx 23/47

Instructions M45PE16

### 6.7 Page write (PW)

The page write (PW) instruction allows bytes to be written in the memory. Before it can be accepted, a write enable (WREN) instruction must previously have been executed. After the write enable (WREN) instruction has been decoded, the device sets the write enable latch (WEL).

The page write (PW) instruction is entered by driving Chip Select  $(\overline{S})$  Low, followed by the instruction code, three address bytes and at least one data byte on serial data input (D). The rest of the page remains unchanged if no power failure occurs during this write cycle.

The page write (PW) instruction performs a page erase cycle even if only one byte is updated.

If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data exceeding the addressed page boundary roll over, and are written from the start address of the same page (the one whose 8 least significant address bits (A7-A0) are all zero). Chip Select  $(\overline{S})$  must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 12.

If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be written correctly within the same page. If less than 256 data bytes are sent to device, they are correctly written at the requested addresses without having any effects on the other bytes of the same page.

For optimized timings, it is recommended to use the page write (PW) instruction to write all consecutive targeted bytes in a single sequence versus using several page write (PW) sequences with each containing only a few bytes (see *Table 12: AC characteristics - 50 MHz operation*).

Chip Select  $(\overline{S})$  must be driven High after the eighth bit of the last data byte has been latched in, otherwise the page write (PW) instruction is not executed.

As soon as Chip Select  $(\overline{S})$  is driven High, the self-timed page write cycle (whose duration is  $t_{PW}$ ) is initiated. While the page write cycle is in progress, the status register may be read to check the value of the write in progress (WIP) bit. The write in progress (WIP) bit is 1 during the self-timed page write cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the write enable latch (WEL) bit is reset.

A page write (PW) instruction applied to a page that is hardware protected is not executed.

Any page write (PW) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

M45PE16 Instructions

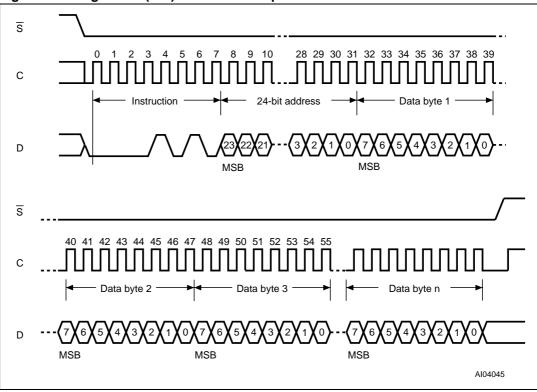


Figure 12. Page write (PW) instruction sequence

- 1. Address bits A23 to A21 are don't care.
- $2. \quad 1 \leq n \leq 256.$

Instructions M45PE16

#### 6.8 Page program (PP)

The page program (PP) instruction allows bytes to be programmed in the memory (changing bits from '1' to '0', only). Before it can be accepted, a write enable (WREN) instruction must previously have been executed. After the write enable (WREN) instruction has been decoded, the device sets the write enable latch (WEL).

The page program (PP) instruction is entered by driving Chip Select  $(\overline{S})$  Low, followed by the instruction code, three address bytes and at least one data byte on serial data input (D). If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data exceeding the addressed page boundary roll over, and are programmed from the start address of the same page (the one whose 8 least significant address bits (A7-A0) are all zero). Chip Select  $(\overline{S})$  must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 13.

If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be programmed correctly within the same page. If less than 256 data bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other bytes of the same page.

For optimized timings, it is recommended to use the page program (PP) instruction to program all consecutive targeted bytes in a single sequence versus using several page program (PP) sequences with each containing only a few bytes (see *Table 12: AC characteristics - 50 MHz operation* and *Table 13: AC characteristics - 75 MHz operation*).

Chip Select  $(\overline{S})$  must be driven High after the eighth bit of the last data byte has been latched in, otherwise the page program (PP) instruction is not executed.

As soon as Chip Select  $(\overline{S})$  is driven High, the self-timed page program cycle (whose duration is  $t_{PP}$ ) is initiated. While the page program cycle is in progress, the status register may be read to check the value of the write in progress (WIP) bit. The write in progress (WIP) bit is 1 during the self-timed page program cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the write enable latch (WEL) bit is reset.

A page program (PP) instruction applied to a page that is hardware protected is not executed.

Any page program (PP) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

M45PE16 Instructions

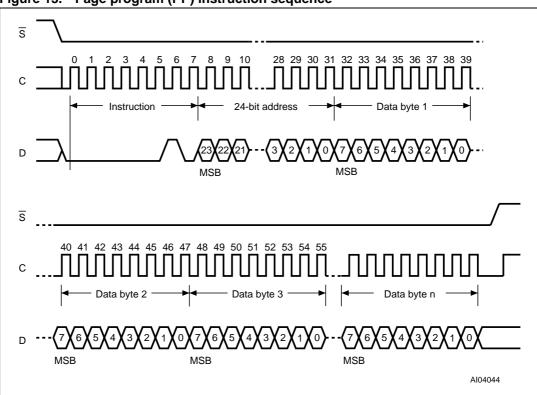


Figure 13. Page program (PP) instruction sequence

2.  $1 \le n \le 256$ .

<sup>1.</sup> Address bits A23 to A21 are don't care.

Instructions M45PE16

### 6.9 Page erase (PE)

The page erase (PE) instruction sets to '1' (FFh) all bits inside the chosen page. Before it can be accepted, a write enable (WREN) instruction must previously have been executed. After the write enable (WREN) instruction has been decoded, the device sets the write enable latch (WEL).

The page erase (PE) instruction is entered by driving Chip Select  $(\overline{S})$  Low, followed by the instruction code, and three address bytes on serial data input (D). Any address inside the page is a valid address for the page erase (PE) instruction. Chip Select  $(\overline{S})$  must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 14.

Chip Select  $(\overline{S})$  must be driven High after the eighth bit of the last address byte has been latched in, otherwise the page erase (PE) instruction is not executed. As soon as Chip Select  $(\overline{S})$  is driven High, the self-timed page erase cycle (whose duration is  $t_{PE}$ ) is initiated. While the page erase cycle is in progress, the status register may be read to check the value of the write in progress (WIP) bit. The write in progress (WIP) bit is 1 during the self-timed page erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the write enable latch (WEL) bit is reset.

A page erase (PE) instruction applied to a page that is hardware protected is not executed.

Any page erase (PE) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

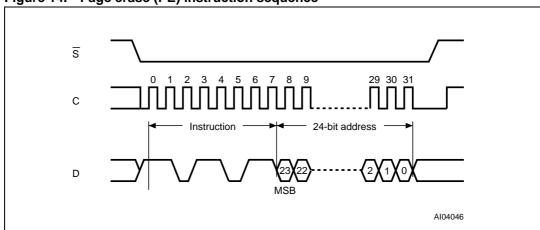


Figure 14. Page erase (PE) instruction sequence

1. Address bits A23 to A21 are don't care.

 M45PE16 Instructions

#### 6.10 Sector erase (SE)

The sector erase (SE) instruction sets to '1' (FFh) all bits inside the chosen sector. Before it can be accepted, a write enable (WREN) instruction must previously have been executed. After the write enable (WREN) instruction has been decoded, the device sets the write enable latch (WEL).

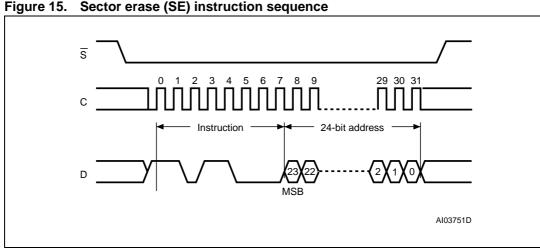
The sector erase (SE) instruction is entered by driving Chip Select  $(\overline{S})$  Low, followed by the instruction code, and three address bytes on serial data input (D). Any address inside the sector (see Table 3) is a valid address for the sector erase (SE) instruction. Chip Select (S) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in *Figure 15*.

Chip Select  $(\overline{S})$  must be driven High after the eighth bit of the last address byte has been latched in, otherwise the sector erase (SE) instruction is not executed. As soon as Chip Select (S) is driven High, the self-timed sector erase cycle (whose duration is  $t_{SF}$ ) is initiated. While the sector erase cycle is in progress, the status register may be read to check the value of the write in progress (WIP) bit. The write in progress (WIP) bit is 1 during the self-timed sector erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the write enable latch (WEL) bit is reset.

A sector erase (SE) instruction applied to a sector that contains a page that is hardware protected is not executed.

Any sector erase (SE) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.



1. Address bits A23 to A21 are don't care.

Instructions M45PE16

### 6.11 Deep power-down (DP)

Executing the deep power-down (DP) instruction is the only way to put the device in the lowest consumption mode (the deep power-down mode). It can also be used as an extra software protection mechanism, while the device is not in active use, since in this mode, the device ignores all write, program and erase instructions.

Driving Chip Select  $(\overline{S})$  High deselects the device, and puts the device in the standby mode (if there is no internal cycle currently in progress). But this mode is not the deep power-down mode. The deep power-down mode can only be entered by executing the deep power-down (DP) instruction, to reduce the standby current (from  $I_{CC1}$  to  $I_{CC2}$ , as specified in *Table 11: DC characteristics*).

Once the device has entered the deep power-down mode, all instructions are ignored except the release from deep power-down (RDP) instruction. This releases the device from this mode.

The deep power-down mode automatically stops at power-down, and the device always powers-up in the standby mode.

The deep power-down (DP) instruction is entered by driving Chip Select  $(\overline{S})$  Low, followed by the instruction code on serial data input (D). Chip Select  $(\overline{S})$  must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 16.

Chip Select  $(\overline{S})$  must be driven High after the eighth bit of the instruction code has been latched in, otherwise the deep power-down (DP) instruction is not executed. As soon as Chip Select  $(\overline{S})$  is driven High, it requires a delay of  $t_{DP}$  before the supply current is reduced to  $t_{CC2}$  and the deep power-down mode is entered.

Any deep power-down (DP) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

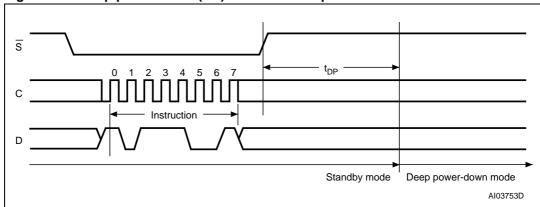


Figure 16. Deep power-down (DP) instruction sequence

M45PE16 Instructions

### 6.12 Release from deep power-down (RDP)

Once the device has entered the deep power-down mode, all instructions are ignored except the release from deep power-down (RDP) instruction. Executing this instruction takes the device out of the deep power-down mode.

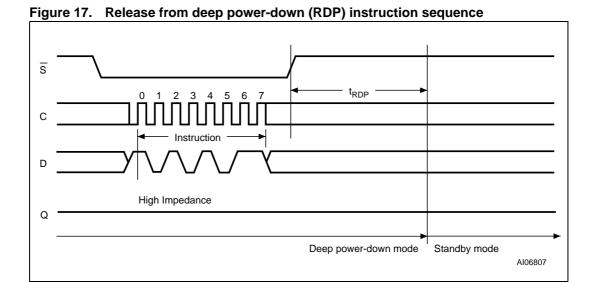
The release from deep power-down (RDP) instruction is entered by driving Chip Select  $(\overline{S})$  Low, followed by the instruction code on serial data input (D). Chip Select  $(\overline{S})$  must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in *Figure 17*.

The release from deep power-down (RDP) instruction is terminated by driving Chip Select  $(\overline{S})$  High. Sending additional clock cycles on Serial Clock (C), while Chip Select  $(\overline{S})$  is driven Low, cause the instruction to be rejected, and not executed.

After Chip Select  $(\overline{S})$  has been driven High, followed by a delay,  $t_{RDP}$  the device is put in the standby mode. Chip Select  $(\overline{S})$  must remain High at least until this period is over. The device waits to be selected, so that it can receive, decode and execute instructions.

Any release from deep power-down (RDP) instruction, while an erase, program or write cycle is in progress, is rejected without having any effects on the cycle that is in progress.



### 7 Power-up and power-down

At power-up and power-down, the device must not be selected (that is Chip Select  $(\overline{S})$  must follow the voltage applied on  $V_{CC}$ ) until  $V_{CC}$  reaches the correct value:

- V<sub>CC</sub>(min) at power-up, and then for a further delay of t<sub>VSL</sub>
- V<sub>SS</sub> at power-down

A safe configuration is provided in Section 3: SPI modes.

To avoid data corruption and inadvertent write operations during power up, a power on reset (POR) circuit is included. The logic inside the device is held reset while  $V_{CC}$  is less than the POR threshold value,  $V_{WI}$  – all operations are disabled, and the device does not respond to any instruction.

Moreover, the device ignores all write enable (WREN), page write (PW), page program (PP), page erase (PE) and sector erase (SE) instructions until a time delay of  $t_{PUW}$  has elapsed after the moment that  $V_{CC}$  rises above the  $V_{WI}$  threshold. However, the correct operation of the device is not guaranteed if, by this time,  $V_{CC}$  is still below  $V_{CC}$ (min). No write, program or erase instructions should be sent until the later of:

- t<sub>PUW</sub> after V<sub>CC</sub> passed the V<sub>WI</sub> threshold
- t<sub>VSI</sub> after V<sub>CC</sub> passed the V<sub>CC</sub>(min) level

These values are specified in Table 6.

If the delay,  $t_{VSL}$ , has elapsed, after  $V_{CC}$  has risen above  $V_{CC}$ (min), the device can be selected for read instructions even if the  $t_{PLIW}$  delay is not yet fully elapsed.

As an extra protection, the Reset (Reset) signal could be driven Low for the whole duration of the power-up and power-down phases.

At power-up, the device is in the following state:

- The device is in the standby mode (not the deep power-down mode).
- The write enable latch (WEL) bit is reset.
- The write in progress (WIP) bit is reset.

Normal precautions must be taken for supply rail decoupling, to stabilize the  $V_{CC}$  feed. Each device in a system should have the  $V_{CC}$  rail decoupled by a suitable capacitor close to the package pins (generally, this capacitor is of the order of 100 nF).

At power-down, when  $V_{CC}$  drops from the operating voltage, to below the POR threshold value,  $V_{WI}$ , all operations are disabled and the device does not respond to any instruction (the designer needs to be aware that if a power-down occurs while a write, program or erase cycle is in progress, some data corruption can result).

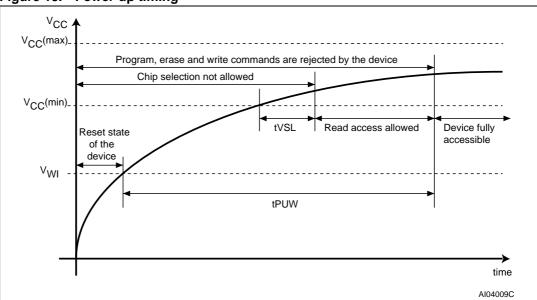


Figure 18. Power-up timing

Table 6. Power-up timing and V<sub>WI</sub> threshold

| Symbol                          | Parameter   | Min | Max | Unit |
|---------------------------------|---|-----|-----|------|
| t <sub>VSL</sub> <sup>(1)</sup> | $V_{CC}(min)$ to $\overline{S}$ low                             | 30  |     | μs   |
| t <sub>PUW</sub> <sup>(1)</sup> | Time delay before the first write, program or erase instruction | 1   | 10  | ms   |
| V <sub>WI</sub> <sup>(1)</sup>  | Write inhibit voltage   | 1.5 | 2.5 | V    |

<sup>1.</sup> These parameters are characterized only, over the temperature range  $-40\,^{\circ}\text{C}$  to  $+85\,^{\circ}\text{C}$ .

Numonyx 33/47

Initial delivery state M45PE16

### 8 Initial delivery state

The device is delivered with the memory array erased: all bits are set to '1' (each byte contains FFh). All usable status register bits are '0'.

# 9 Maximum ratings

Stressing the device above the rating listed in the *Table 7: Absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum ratings conditions for extended periods may affect device reliability.

Table 7. Absolute maximum ratings

| Symbol            | Parameter   |       | Max                   | Unit |
|-------------------|---|-------|-----------------------|------|
| T <sub>STG</sub>  | Storage temperature   | -65   | 150                   | °C   |
| T <sub>LEAD</sub> | Lead temperature during soldering See note (1)                    |       | °C                    |      |
| V <sub>IO</sub>   | Input and output voltage (with respect to ground)                 | -0.6  | V <sub>CC</sub> + 0.6 | V    |
| V <sub>CC</sub>   | Supply voltage  | -0.6  | 4.0                   | V    |
| V <sub>ESD</sub>  | Electrostatic discharge voltage (human body model) <sup>(2)</sup> | -2000 | 2000                  | V    |

Compliant with JEDEC Std J-STD-020C (for small body, Sn-Pb or Pb assembly), the Numonyx ECOPACK® 7191395 specification, and the European directive on Restrictions on Hazardous Substances (RoHS) 2002/95/EU.

<sup>2.</sup> JEDEC Std JESD22-A114A (C1 = 100 pF, R1 = 1500  $\Omega$ , R2 = 500  $\Omega$ ).

### 10 DC and AC parameters

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC characteristics tables that follow are derived from tests performed under the measurement conditions summarized in the relevant tables. Designers should check that the operating conditions in their circuit match the measurement conditions when relying on the quoted parameters.

Table 8. Operating conditions

| Symbol          | Parameter                     | Min | Max | Unit |
|-----------------|-------------------------------|-----|-----|------|
| V <sub>CC</sub> | Supply voltage                | 2.7 | 3.6 | V    |
| T <sub>A</sub>  | Ambient operating temperature | -40 | 85  | °C   |

Table 9. AC test measurement conditions<sup>(1)</sup>

| Symbol         | Parameter Min Max                          |  |  |  |  |  |  |
|----------------|--|--|--|--|--|--|--|
| C <sub>L</sub> | Load capacitance                           | 3  | pF                                       |  |  |  |  |
|                | Input rise and fall times                  |  | 5  |  |  |  |  |
|                | Input pulse voltages                       | 0.2V <sub>CC</sub> t                       | 0.2V <sub>CC</sub> to 0.8V <sub>CC</sub> |  |  |  |  |
|                | Input and output timing reference voltages | 0.3V <sub>CC</sub> to 0.7V <sub>CC</sub> V |  |  |  |  |  |

<sup>1.</sup> Output Hi-Z is defined as the point where data out is no longer driven.

Figure 19. AC test measurement I/O waveform

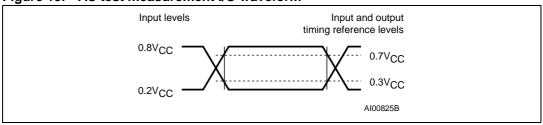


Table 10. Capacitance<sup>(1)</sup>

| Symbol           | Parameter                      | Test condition         | Min | Max | Unit |
|------------------|--------------------------------|------------------------|-----|-----|------|
| C <sub>OUT</sub> | Output capacitance (Q)         | V <sub>OUT</sub> = 0 V |     | 8   | pF   |
| C <sub>IN</sub>  | Input capacitance (other pins) | V <sub>IN</sub> = 0 V  |     | 6   | pF   |

<sup>1.</sup> Sampled only, not 100% tested at  $T_A$  = 25 °C and a frequency of 33 MHz.

№ numonyx 35/47

Table 11. DC characteristics

| Symbol           | Parameter Test condition (in addition to those in <i>Table 8</i> ) |   | Min                  | Max                  | Unit |
|------------------|--|---|----------------------|----------------------|------|
| ILI              | Input leakage current  |   |                      | ± 2                  | μΑ   |
| I <sub>LO</sub>  | Output leakage current   |   |                      | ± 2                  | μA   |
| I <sub>CC1</sub> | Standby current (standby and reset modes)                          | $\overline{S} = V_{CC}, V_{IN} = V_{SS} \text{ or } V_{CC}$                           |                      | 50                   | μA   |
| I <sub>CC2</sub> | Deep power-down current  | $\overline{S} = V_{CC}, V_{IN} = V_{SS} \text{ or } V_{CC}$                           |                      | 10                   | μΑ   |
|                  | Operating current  | $C = 0.1V_{CC} / 0.9.V_{CC}$ at 75 MHz,<br>Q = open                                   |                      | 12                   | m Λ  |
| I <sub>CC3</sub> | (FAST_READ)  | (AST_READ) $C = 0.1V_{CC} / 0.9.V_{CC} \text{ at } 33 \text{ MHz},$ $Q = \text{open}$ |                      | 4                    | mA   |
| I <sub>CC4</sub> | Operating current (PW)   | S = V <sub>CC</sub>   |                      | 15                   | mA   |
| I <sub>CC5</sub> | Operating current (SE)   | S = V <sub>CC</sub>   |                      | 15                   | mA   |
| V <sub>IL</sub>  | Input Low voltage  |   | - 0.5                | 0.3V <sub>CC</sub>   | V    |
| $V_{IH}$         | Input High voltage   |   | 0.7V <sub>CC</sub>   | V <sub>CC</sub> +0.4 | V    |
| V <sub>OL</sub>  | Output Low voltage   | I <sub>OL</sub> = 1.6 mA  |                      | 0.4                  | V    |
| V <sub>OH</sub>  | Output High voltage  | I <sub>OH</sub> = -100 μA   | V <sub>CC</sub> -0.2 |                      | V    |

Table 12. AC characteristics - 50 MHz operation

|                                  | Test conditions specified in Table 8 and Table 9 |  |   |     |     |      |  |  |  |  |
|----------------------------------|--|--|---|-----|-----|------|--|--|--|--|
| Symbol                           | Alt.   | Parameter  | Min   | Тур | Max | Unit |  |  |  |  |
| $f_{\mathbb{C}}$                 | f <sub>C</sub>                                   | Clock frequency for the following instructions:<br>FAST_READ, PW, PP, PE, SE, DP, RDP,<br>WREN, WRDI, RDSR, RDID | D.C.  |     | 50  | MHz  |  |  |  |  |
| f <sub>R</sub>                   |  | Clock frequency for read instructions  | D.C.  |     | 33  | MHz  |  |  |  |  |
| t <sub>CH</sub> <sup>(1)</sup>   | t <sub>CLH</sub>                                 | Clock High time  | 9   |     |     | ns   |  |  |  |  |
| t <sub>CL</sub> <sup>(1)</sup>   | t <sub>CLL</sub>                                 | Clock Low time   | 9   |     |     | ns   |  |  |  |  |
|                                  |  | Clock slew rate <sup>2</sup> (peak to peak)  | 0.1   |     |     | V/ns |  |  |  |  |
| t <sub>SLCH</sub>                | t <sub>CSS</sub>                                 | S active setup time (relative to C)  | 5   |     |     | ns   |  |  |  |  |
| t <sub>CHSL</sub>                |  | S not active hold time (relative to C)   | 5   |     |     | ns   |  |  |  |  |
| t <sub>DVCH</sub>                | t <sub>DSU</sub>                                 | Data in setup time   | 2   |     |     | ns   |  |  |  |  |
| t <sub>CHDX</sub>                | t <sub>DH</sub>                                  | Data in hold time  | 5   |     |     | ns   |  |  |  |  |
| t <sub>CHSH</sub>                |  | S active hold time (relative to C)   | 5   |     |     | ns   |  |  |  |  |
| t <sub>SHCH</sub>                |  | S not active setup time (relative to C)  | 5   |     |     | ns   |  |  |  |  |
| t <sub>SHSL</sub>                | t <sub>CSH</sub>                                 | S deselect time  | 100   |     |     | ns   |  |  |  |  |
| t <sub>SHQZ</sub> <sup>(2)</sup> | t <sub>DIS</sub>                                 | Output disable time  |   |     | 8   | ns   |  |  |  |  |
| t <sub>CLQV</sub>                | t <sub>V</sub>                                   | Clock Low to Output Valid  |   |     | 8   | ns   |  |  |  |  |
| t <sub>CLQX</sub>                | t <sub>HO</sub>                                  | Output hold time   | 0   |     |     | ns   |  |  |  |  |
| t <sub>WHSL</sub>                |  | Write protect setup time   | 50  |     |     | ns   |  |  |  |  |
| t <sub>SHWL</sub>                |  | Write protect hold time  | 100   |     |     | ns   |  |  |  |  |
| t <sub>DP</sub> <sup>(2)</sup>   |  | S to deep power-down   |   |     | 3   | μs   |  |  |  |  |
| t <sub>RDP</sub> <sup>(2)</sup>  |  | S High to standby mode   |   |     | 30  | μs   |  |  |  |  |
| t <sub>RLRH</sub> <sup>(2)</sup> | t <sub>RST</sub>                                 | Reset pulse width  |   |     | 10  | μs   |  |  |  |  |
| t <sub>RHSL</sub>                | t <sub>REC</sub>                                 | Reset recovery time  |   |     | 3   | μs   |  |  |  |  |
| t <sub>SHRH</sub>                |  | Chip should have been deselected before reset is de-asserted   |   |     | 10  | ns   |  |  |  |  |
| t <sub>PW</sub> <sup>(3)</sup>   |  | Page write cycle time (256 bytes)  |   | 11  | 23  | ms   |  |  |  |  |
|                                  |  | Page program cycle time (256 bytes) 0.8  |   | 0.8 | _   | n    |  |  |  |  |
| t <sub>PP</sub> <sup>(3)</sup>   |  | Page program cycle time (n Bytes)  | gram cycle time (n Bytes) $int(n/8) \times 0.0$ |     | - 3 | ms   |  |  |  |  |
| t <sub>PE</sub>                  |  | Page erase cycle time  |   | 10  | 20  | ms   |  |  |  |  |
| t <sub>SE</sub>                  |  | Sector erase cycle time  |   | 1   | 5   | s    |  |  |  |  |

<sup>1.</sup>  $t_{CH} + t_{CL}$  must be greater than or equal to 1/  $f_{C}$ .

Numonyx 37/47

<sup>2.</sup> Value guaranteed by characterization, not 100% tested in production.

<sup>3.</sup> n = number of bytes to program. int(A) corresponds to the upper integer part of A. Examples: <math>int(1/8) = 1, int(16/8) = 2, int(17/8) = 3.

Table 13. AC characteristics - 75 MHz operation<sup>(1)</sup>

| Test conditions specified in Table 8 and Table 9 |                                     |  |                   |                               |     |      |  |  |
|--|-------------------------------------|--|-------------------|-------------------------------|-----|------|--|--|
| Symbol   | Alt.                                | Parameter  | Parameter Min Typ |                               |     |      |  |  |
| f <sub>C</sub>                                   | f <sub>C</sub>                      | Clock frequency for the following instructions:<br>FAST_READ, PW, PP, PE, SE, DP, RDP, WREN,<br>WRDI, RDSR, RDID | D.C.              |                               | 75  | MHz  |  |  |
| f <sub>R</sub>                                   |                                     | Clock frequency for read instructions  | D.C.              |                               | 33  | MHz  |  |  |
| t <sub>CH</sub> <sup>(2)</sup>                   | t <sub>CLH</sub>                    | Clock High time  | 6                 |                               |     | ns   |  |  |
| t <sub>CL</sub> <sup>(2)</sup>                   | t <sub>CLL</sub>                    | Clock Low time   | 6                 |                               |     | ns   |  |  |
|  |                                     | Clock slew rate <sup>(3)</sup> (peak to peak)  | 0.1               |                               |     | V/ns |  |  |
| t <sub>SLCH</sub>                                | t <sub>CSS</sub>                    | S active setup time (relative to C)  | 5                 |                               |     | ns   |  |  |
| t <sub>CHSL</sub>                                |                                     | S not active hold time (relative to C)   | 5                 |                               |     | ns   |  |  |
| t <sub>DVCH</sub>                                | t <sub>DSU</sub>                    | Data in setup time   | 2                 |                               |     | ns   |  |  |
| t <sub>CHDX</sub>                                | t <sub>DH</sub>                     | Data in hold time  | 5                 |                               |     | ns   |  |  |
| t <sub>CHSH</sub>                                |                                     | S active hold time (relative to C)   | 5                 |                               |     | ns   |  |  |
| t <sub>SHCH</sub>                                |                                     | S not active setup time (relative to C)  | 5                 |                               |     | ns   |  |  |
| t <sub>SHSL</sub>                                | t <sub>CSH</sub>                    | S deselect time  | 100               |                               |     | ns   |  |  |
| t <sub>SHQZ</sub> (3)                            | t <sub>DIS</sub>                    | Output disable time  |                   |                               | 8   | ns   |  |  |
| t <sub>CLQV</sub>                                | t <sub>V</sub>                      | Clock Low to Output valid under 30 pF/10 pF  |                   |                               | 8/6 | ns   |  |  |
| t <sub>CLQX</sub>                                | t <sub>HO</sub>                     | Output hold time   | 0                 |                               |     | ns   |  |  |
| t <sub>WHSL</sub> <sup>(4)</sup>                 |                                     | Write protect setup time   | 20                |                               |     | ns   |  |  |
| t <sub>SHWL</sub> <sup>(4)</sup>                 |                                     | Write protect hold time  | 100               |                               |     | ns   |  |  |
| t <sub>DP</sub> <sup>(3)</sup>                   |                                     | S to deep power-down   |                   |                               | 3   | μs   |  |  |
| t <sub>RDP</sub> <sup>(3)</sup>                  |                                     | S High to standby mode   |                   |                               | 30  | μs   |  |  |
| t <sub>W</sub>                                   |                                     | Write status register cycle time   |                   | 3                             | 15  | ms   |  |  |
| t <sub>PW</sub> <sup>(5)</sup>                   |                                     | Page write cycle time (256 bytes)  |                   | 11                            | 23  | ms   |  |  |
| t <sub>PP</sub> <sup>(5)</sup>                   | Page program cycle time (256 bytes) |  | 0.8               | 3                             | ma  |      |  |  |
| 'PP'-'   |                                     | Page program cycle time (n bytes)  |                   | $int(n/8) \times 0.025^{(6)}$ | 3   | ms   |  |  |
| t <sub>PE</sub>                                  |                                     | Page erase cycle time  |                   | 10                            | 20  | ms   |  |  |
| t <sub>SE</sub>                                  |                                     | Sector erase cycle time  |                   | 1                             | 5   | S    |  |  |

<sup>1.</sup> Delivery of parts operating with a maximum clock rate of 75 MHz starts from week 8 of 2008 (see *Important note on page 6*).

- 2.  $t_{CH} + t_{CL}$  must be greater than or equal to 1/  $f_{C}$ .
- 3. Value guaranteed by characterization, not 100% tested in production.
- 4. Only applicable as a constraint for a WRSR instruction when SRWD is set to '1'.
- When using PP and PW instructions to update consecutive bytes, optimized timings are obtained with one sequence including all the bytes versus several sequences of only a few bytes (1 ≤ n ≤ 256).
- 6. int(A) corresponds to the upper integer part of A. For instance, int(12/8) = 2, int(32/8) = 4 int(15.3) = 16.

Figure 20. Serial input timing

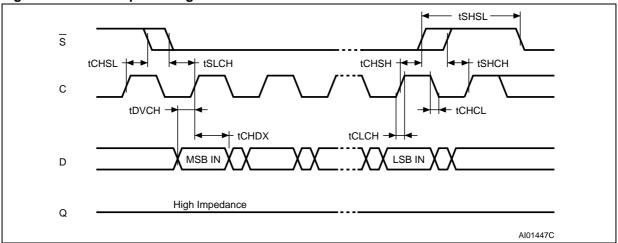
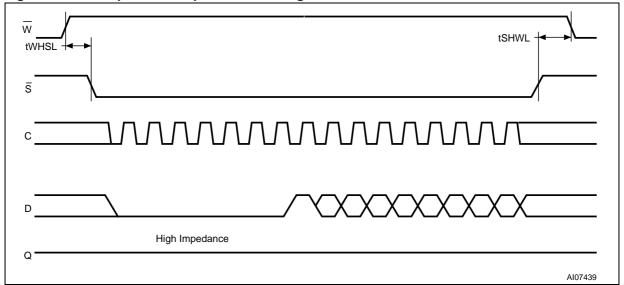
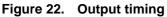
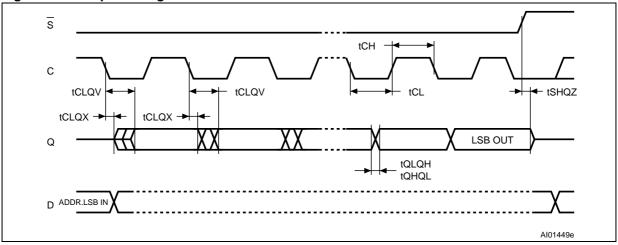


Figure 21. Write protect setup and hold timing







Numonyx 39/47

Table 14. Reset conditions

|                                  | Test conditions specified in Table 8 and Table 9 |                                   |  |     |     |     |      |  |  |  |  |
|----------------------------------|--|-----------------------------------|--|-----|-----|-----|------|--|--|--|--|
| Symbol                           | Alt.   | Parameter                         | Conditions   | Min | Тур | Max | Unit |  |  |  |  |
| t <sub>RLRH</sub> <sup>(1)</sup> | t <sub>RST</sub>                                 | Reset pulse width                 | 10   |     |     | μs  |      |  |  |  |  |
| t <sub>SHRH</sub>                |  | Chip Select High to<br>Reset High | Chip should have been deselected before reset is de-asserted | 10  |     |     | ns   |  |  |  |  |

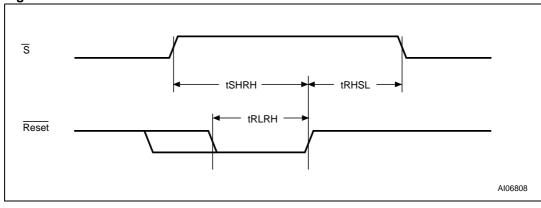
<sup>1.</sup> Value guaranteed by characterization, not 100% tested in production.

Table 15. Timings after a Reset Low pulse<sup>(1)</sup>

|                   | Test conditions specified in <i>Table 8</i> and <i>Table 9</i> |  |   |     |      |    |    |  |  |  |  |
|-------------------|--|--|---|-----|------|----|----|--|--|--|--|
| Symbol            | Alt.   | Min  | Тур   | Max | Unit |    |    |  |  |  |  |
|                   | t <sub>RHSL</sub> t <sub>REC</sub> Reset recovery time         | While decoding an instruction <sup>(2)</sup> :<br>WREN, WRDI, RDID, RDSR, READ,<br>FAST_READ, PW, PP, PE, SE, DP,<br>RDP |   |     | 30   | μs |    |  |  |  |  |
| t <sub>RHSL</sub> |  | Under completion of an erase or program cycle of a PW, PP, PE, SE operation  |   |     | 300  | μs |    |  |  |  |  |
|                   |  |  | Device deselected (\$\overline{S}\$ High) and in standby mode |     |      | 0  | μs |  |  |  |  |

- 1. All the values are guaranteed by characterization, and not 100% tested in production.
- 2.  $\overline{S}$  remains Low while  $\overline{Reset}$  is Low.

Figure 23. Reset AC waveforms

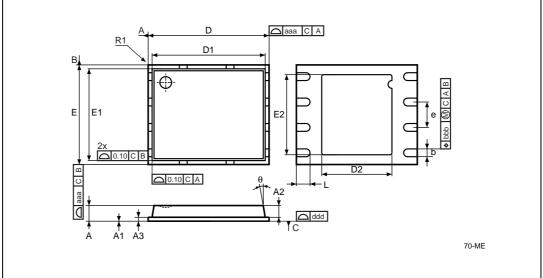


M45PE16 Package mechanical

# 11 Package mechanical

To meet environmental requirements, Numonyx offers these devices in ECOPACK® packages. ECOPACK® packages are lead-free. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label.

Figure 24. VFQFPN8 (MLP8) 8-lead very thin fine pitch quad flat package no lead, 6 × 5 mm, package outline



- 1. Drawing is not to scale.
- 2. The circle in the top view of the package indicates the position of pin 1.

Numonyx 41/47

Package mechanical M45PE16

Table 16. VFQFPN8 (MLP8) 8-lead very thin fine pitch quad flat package no lead, 6 × 5 mm, package mechanical data

| Comple of |      | millimeters |      | inches |       |       |  |
|-----------|------|-------------|------|--------|-------|-------|--|
| Symbol    | Тур  | Min         | Max  | Тур    | Min   | Max   |  |
| Α         | 0.85 | 0.80        | 1.00 | 0.033  | 0.031 | 0.039 |  |
| A1        |      | 0.00        | 0.05 |        | 0.000 | 0.002 |  |
| A2        | 0.65 |             |      | 0.026  |       |       |  |
| A3        | 0.20 |             |      | 0.008  |       |       |  |
| b         | 0.40 | 0.35        | 0.48 | 0.016  | 0.014 | 0.019 |  |
| D         | 6.00 |             |      | 0.236  |       |       |  |
| D1        | 5.75 |             |      | 0.226  |       |       |  |
| D2        | 3.40 | 3.20        | 3.60 | 0.134  | 0.126 | 0.142 |  |
| E         | 5.00 |             |      | 0.197  |       |       |  |
| E1        | 4.75 |             |      | 0.187  |       |       |  |
| E2        | 4.00 | 3.80        | 4.30 | 0.157  | 0.150 | 0.169 |  |
| е         | 1.27 | _           | _    | 0.050  | _     | _     |  |
| R1        | 0.10 | 0.00        |      | 0.004  | 0.000 |       |  |
| L         | 0.60 | 0.50        | 0.75 | 0.024  | 0.020 | 0.029 |  |
| Θ         |      |             | 12°  |        |       | 12°   |  |
| aaa       |      |             | 0.15 |        |       | 0.006 |  |
| bbb       |      |             | 0.10 |        |       | 0.004 |  |
| ddd       |      |             | 0.05 |        |       | 0.002 |  |

M45PE16 Package mechanical

Figure 25. SO8W - 8 lead plastic small outline, 208 mils body width, package outline

1. Drawing is not to scale.

Table 17. SO8W - 8 lead plastic small outline, 208 mils body width, package mechanical data

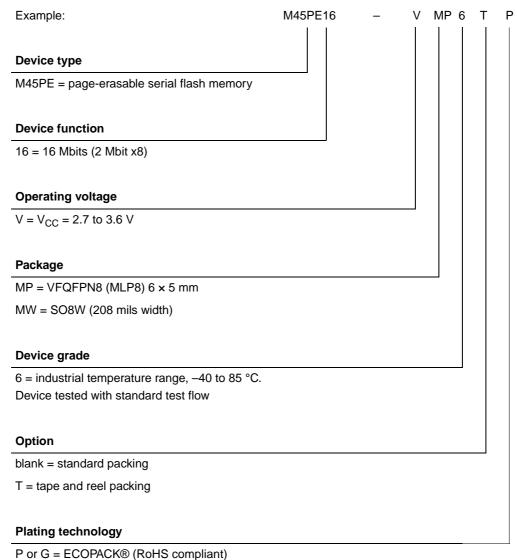
| Symbol             |         | millimeters |      | inches |       |       |
|--------------------|---------|-------------|------|--------|-------|-------|
| Symbol             | Тур     | Min         | Max  | Тур    | Min   | Max   |
| А                  |         |             | 2.50 |        |       | 0.098 |
| A1                 |         | 0.00        | 0.25 |        | 0.000 | 0.010 |
| A2                 |         | 1.51        | 2.00 |        | 0.059 | 0.079 |
| b                  | 0.40    | 0.35        | 0.51 | 0.016  | 0.014 | 0.020 |
| С                  | 0.20    | 0.10        | 0.35 | 0.008  | 0.004 | 0.014 |
| СР                 |         |             | 0.10 |        |       | 0.004 |
| D                  |         |             | 6.05 |        |       | 0.238 |
| Е                  |         | 5.02        | 6.22 |        | 0.198 | 0.245 |
| E1                 |         | 7.62        | 8.89 |        | 0.300 | 0.350 |
| е                  | 1.27    | _           | -    | 0.050  | -     | -     |
| k                  |         | 0°          | 10°  |        | 0°    | 10°   |
| L                  |         | 0.50        | 0.80 |        | 0.020 | 0.031 |
| N (number of pins) | ns) 8 8 |             |      |        |       |       |

Numonyx 43/47

Ordering information M45PE16

# 12 Ordering information

Table 18. Ordering information scheme



F OI G = ECOPACK® (NOI IS compliant

Note: For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest Numonyx sales office.

M45PE16 Revision history

# 13 Revision history

Table 19. Document revision history

| Date          | Version | Changes   |
|---------------|---------|---|
| 30-Apr-2003   | 1.0     | Initial release.  |
| 04-Jun-2003   | 1.1     | Description corrected of entering hardware protected mode ( $\overline{W}$ must be driven, and cannot be left unconnected).   |
| 26-Nov-2003   | 2.0     | $V_{\text{IO}}(\text{min})$ extended to -0.6V, and $t_{\text{PW}}(\text{typ})$ , $t_{\text{PP}}(\text{typ})$ improved. $t_{\text{WHSL}}$ and $t_{\text{SHWL}}$ added. MLP8 and SO16 pages added, and LGA package removed. Table of contents, and Pb-free options added.   |
| 31-Mar-2004   | 2.1     | Document promoted to product preview.   |
| 23-Jul-2004   | 2.2     | SO connections illustration corrected. Wording clarified for device grade in ordering information table.  |
| 04-Aug-2005   | 3       | An easy way to modify data, A fast way to modify data, Page write (PW) and Page program (PP) sections updated to explain optimal use of page write and page program instructions. Table 12: AC characteristics - 50 MHz operation updated.  |
| 15-Jun-2006   | 4       | Document put in new template.  t <sub>SHQZ</sub> end timing line modified in <i>Figure 22: Output timing</i> .  Packages are ECOPACK® compliant. VDFPN and SO16W packages removed. SO8W and VFQFPN8 packages added (see <i>Section 11: Package mechanical</i> ). Blank option removed below <i>Plating technology</i> in <i>Table 18: Ordering information scheme</i> .  Document status promoted to preliminary data.  |
| 16-Oct-2006   | 5       | 50 MHz frequency added, 25 MHz frequency removed.  Figure 3: Bus master and memory devices on the SPI bus modified,  Note 1 modified, Note 2 added. Small text changes.  I <sub>CC3</sub> updated in Table 11: DC characteristics.  Table 12: AC characteristics - 50 MHz operation updated.  V <sub>IO</sub> max modified in Table 7: Absolute maximum ratings.  f <sub>R</sub> , t <sub>PW</sub> , t <sub>PP</sub> updated in Table 12: AC characteristics - 50 MHz operation.  |
| 09-Feb-2007 6 |         | Section 2.5: Reset (Reset) modified and the signal can no longer be driven Low to protect the array at a critical time. Section 2.7: VCC supply voltage and Section 2.8: VSS ground added.  Figure 3: Bus master and memory devices on the SPI bus modified and explanatory paragraph added.  At power-up The write in progress (WIP) bit is reset.  Note modified below Table 10: Capacitance.  Table 14: Reset conditions and Table 15: Timings after a Reset Low pulse added. Small text changes.  Packages specifications updated (see Section 11: Package mechanical). |

Numonyx 45/47

Revision history M45PE16

Table 19. Document revision history (continued)

| Date        | Version | Changes  |
|-------------|---------|--|
| 10-Dec-2007 | 7       | Applied Numonyx branding.  |
| 15-May-2008 | 8       | Document status promoted from preliminary data to datasheet. Removed 'low voltage' from the title. Updated the value for the maximum clock frequency (from 50 to 75 MHz) throughout the document. Added: Table 13: AC characteristics - 75 MHz operation and ECOPACK® text in Section 11: Package mechanical. Modified: Table 11: DC characteristics, Figure 3: Bus master and memory devices on the SPI bus, Section 3: SPI modes, and Section 6.3: Read identification (RDID). |

#### Please Read Carefully:

INFORMATION IN THIS DOCUMENT IS PROVIDED IN CONNECTION WITH NUMONYX™ PRODUCTS. NO LICENSE, EXPRESS OR IMPLIED, BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT. EXCEPT AS PROVIDED IN NUMONYX'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, NUMONYX ASSUMES NO LIABILITY WHATSOEVER, AND NUMONYX DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY, RELATING TO SALE AND/OR USE OF NUMONYX PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

Numonyx products are not intended for use in medical, life saving, life sustaining, critical control or safety systems, or in nuclear facility applications.

Numonyx may make changes to specifications and product descriptions at any time, without notice.

Numonyx, B.V. may have patents or pending patent applications, trademarks, copyrights, or other intellectual property rights that relate to the presented subject matter. The furnishing of documents and other materials and information does not provide any license, express or implied, by estoppel or otherwise, to any such patents, trademarks, copyrights, or other intellectual property rights.

Designers must not rely on the absence or characteristics of any features or instructions marked "reserved" or "undefined." Numonyx reserves these for future definition and shall have no responsibility whatsoever for conflicts or incompatibilities arising from future changes to them.

Contact your local Numonyx sales office or your distributor to obtain the latest specifications and before placing your product order.

Copies of documents which have an order number and are referenced in this document, or other Numonyx literature may be obtained by visiting Numonyx's website at http://www.numonyx.com.

Numonyx StrataFlash is a trademark or registered trademark of Numonyx or its subsidiaries in the United States and other countries.

\*Other names and brands may be claimed as the property of others.

Copyright © 11/5/7, Numonyx, B.V., All Rights Reserved.

Numonyx 47/47